Search Notes					

Application/Control No.	Applicant(s)/Patent under Reexamination
10/749,076	MARTIN ET AL.
Examiner	Art Unit
Kim T. Huynh	2112

SEARCHED				
Class	Subclass	Date	Examiner	
710	301-304	3/16/2006	кн	
710	100, 117	3/16/2006	КН	
710	124	8/17/2006	кн	
-				

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
710	301	8/17/2006	КН	
710	117, 124	3/17/2006	КН	
710	25	8/17/2006	кн	
			:	

SEARCH NO (INCLUDING SEARCH)
	DATE	EXMR
East search uspat, uspgpub, epo, jpo, derwent	3/16/2006	кн
updated prior search	8/17/2006	КН
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